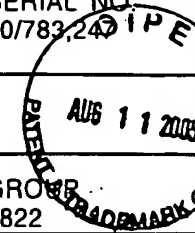


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OK	AR	ASM Handbook, Vol. 3, Alloy Phase Diagrams, 1992, pg. 375						
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EXAMINER <i>Christy Horacek</i>				DATE CONSIDERED 10/26/05				
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		Document Number	Date	Country	Class	Sub- class	Translation	
							Yes	No
	AK							
	AM							
	AN							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
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